

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10020420	EDARA ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	Qing Chen	2191

## SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
717	139	12/3/2008	/QC/
712	208-213, 245-248	12/3/2008	/QC/

## SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Updated EAST Search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB) -- See Search History Printout	12/3/2008	/QC/
717/139; 712/208-213, 245-248 (limited class search)	12/3/2008	/QC/
Updated EAST Inventor Name Search and Assignee Search (US-PGPUB; USPAT) -- See Search History Printout	12/3/2008	/QC/
NPL Search (ACM; Google) -- See Printout	12/4/2008	/QC/
Updated PALM Inventor Name Search	12/5/2008	/QC/
Consulted Primary Examiner Richard Ellis regarding search strategy	12/4/2008	/QC/
Consulted SPE Wei Zhen (AU 2191)	12/4/2008	/QC/

## INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
717	139	12/3/2008	/QC/
712	208-213, 245-248	12/3/2008	/QC/

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